



Voltage Regulators

LM114/LM114A/LM115/LM115A transistor pairs

general description

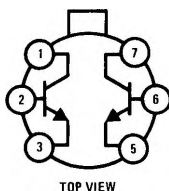
These devices contain a pair of junction-isolated NPN transistors fabricated on a single silicon substrate. This monolithic structure makes possible extremely-tight parameter matching at low cost. Further, advanced processing techniques yield exceptionally high current gains at low collector currents, virtual elimination of "popcorn noise," low leakages and improved long-term stability. Some of the major features of these pairs are indicated by the following specifications:

- Low offset voltage—0.5 mV maximum
- Low drift— $2 \mu\text{V}/^\circ\text{C}$ maximum from -55°C to 125°C

- High current gain—500 minimum at $10 \mu\text{A}$
- Tight beta match—10% maximum
- High breakdown voltage—to 60V
- Matching guaranteed over a 0V to 45V collector-base voltage range.

Although designed primarily for high breakdown voltage and exceptional dc characteristics, these transistors have surprisingly good high-frequency performance. The gain-bandwidth product is 450 MHz with 1 mA collector current and 5V collector-base voltage and 22 MHz with $10 \mu\text{A}$ collector current. Collector-base capacitance is only 1.3 pF at 5V.

connection diagram



absolute maximum ratings

	LM114 LM114A	LM115 LM115A
Collector-Base Voltage (BV_{CBO})	45V	60V
Collector-Emitter Voltage (BV_{CER})	45V	60V
Collector-Collector Voltage	45V	60V
Emitter-Emitter Voltage	45V	60V
Emitter-Base Voltage (BV_{EBO})	6V	
Collector Current	20 mA	
Total Power Dissipation (Note 1)	1.8W	
Operating Junction Temperature	-55°C to 150°C	
Storage Temperature	-65°C to 150°C	
Lead Temperature (soldering, 10 sec)	300°C	

Note 1: The maximum dissipation given is for a 25°C case temperature. For operation under other conditions, the device must be derated based on a 150°C maximum junction temperature and a thermal resistance of $70^\circ\text{C}/\text{W}$ junction to case or $230^\circ\text{C}/\text{W}$ junction to ambient.

electrical characteristics (Note 2)

PARAMETER	CONDITIONS	MAXIMUM LIMITS				UNITS
		LM114	LM114A	LM115	LM115A	
Offset Voltage	$1\ \mu\text{A} \leq I_C \leq 100\ \mu\text{A}$	2.0	0.5	2.0	0.5	mV
Offset Current	$I_C = 10\ \mu\text{A}$	10	2.0	10	2.0	nA
	$I_C = 1\ \mu\text{A}$		0.5		0.5	nA
Bias Current	$I_C = 10\ \mu\text{A}$	40	20	40	40	nA
	$I_C = 1\ \mu\text{A}$		3.0		6.0	nA
Offset Voltage Change	$0\text{V} \leq V_{CB} \leq V_{\max}$ $I_C = 10\ \mu\text{A}$	1.5	0.2	2.0	0.3	mV
Offset Current Change	$0\text{V} \leq V_{CB} \leq V_{\max}$ $I_C = 10\ \mu\text{A}$	4.0	1.0	4.0	1.0	nA
Offset Voltage Drift	$-55^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$ $I_C = 10\ \mu\text{A}$	10	2.0	10	2.0	$\mu\text{V}/^\circ\text{C}$
Offset Current	$-55^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$ $I_C = 10\ \mu\text{A}$	50	12	50	20	nA
Bias Current	$-55^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$ $I_C = 10\ \mu\text{A}$	150	60	150	150	nA
Collector-Base Leakage Current	$V_{CB} = V_{\max}$ $T_A = 25^\circ\text{C}$	50	10	50	10	pA
	$T_A = 125^\circ\text{C}$	50	10	50	10	nA
Collector-Emitter Leakage Current	$V_{CE} = V_{\max}, V_{EB} = 0$ $T_A = 25^\circ\text{C}$	200	50	200	50	pA
	$T_A = 125^\circ\text{C}$	200	50	200	50	nA
Collector-Collector Leakage Current	$V_{CC} = V_{\max}$ $T_A = 25^\circ\text{C}$	300	100	300	100	pA
	$T_A = 125^\circ\text{C}$	300	100	300	100	nA

Note 2: These specifications apply for $T_A = 25^\circ\text{C}$ and $0\text{V} \leq V_{CB} \leq V_{\max}$, unless otherwise specified. For the LM114 and LM114A, $V_{\max} = 30\text{V}$. For the LM115 and LM115A, $V_{\max} = 45\text{V}$.

typical performance